

# SILICON CARBIDE 1200 V / 160 mΩ POWER MOSFET DIE

## Applications:

- Solar inverters
- Switched-mode power supply
- High voltage DC/DC converters
- Battery charges
- Motor drives
- Pulsed power application

## Features:

- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Easy to parallel and simple to drive
- Avalanche ruggedness
- Resistant to latch-up
- Silver backside metal

## Maximum Ratings ( $T_A = 25\text{ °C}$ , unless otherwise specified)

Characteristics	Symbol	Conditions	Min.	Typ.	Max.	Units	Note
Drain - Source Voltage	$V_{DSmax}$	$V_{GS} = 0\text{ V}$ , $I_D = 100\text{ }\mu\text{A}$			1200	V	
Gate - Source Voltage (dynamic)	$V_{GSmax}$	AC ( $f > 1\text{ Hz}$ )	-10		+25	V	
Gate - Source Voltage (static)	$V_{GSop}$	Static		-5 / +20		V	[1]
Continuous Drain Current	$I_D$	$V_{GS} = 20\text{ V}$ , $T_C = 25\text{ °C}$			17	A	
		$V_{GS} = 20\text{ V}$ , $T_C = 100\text{ °C}$			12		
Pulsed Drain Current	$I_{D(pulse)}$	Pulse width $t_P$ limited by $T_{Jmax}$			40	A	
Operating Junction and Storage Temperature	$T_J$ , $T_{stg}$				-55 to 175	°C	
Maximum Processing Temperature	$T_{Proc}$	10 min. maximum			325	°C	

[1] Recommended turn off gate voltage is -5 V. Recommended turn on gate voltage is 20 V. Do not use with  $V_{GSon} < 15\text{ V}$ .

## Electrical Characteristics ( $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified)

Characteristics	Symbol	Conditions	Min.	Typ.	Max.	Units
Drain Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$ , $I_D = 100\text{ }\mu\text{A}$	1200			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 2.5\text{ mA}$	2	2.8	4	V
		$V_{DS} = V_{GS}$ , $I_D = 2.5\text{ mA}$ , $T_J = 175\text{ }^\circ\text{C}$		1.9		V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$		1	100	$\mu\text{A}$
Gate Source Leakage Current	$I_{GSS}$	$V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$		10	250	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 20\text{ V}$ , $I_D = 10\text{ A}$		175	196	$\text{m}\Omega$
		$V_{GS} = 20\text{ V}$ , $I_D = 10\text{ A}$ , $T_J = 175\text{ }^\circ\text{C}$		300		$\text{m}\Omega$
Transconductance	gfs	$V_{DS} = 20\text{ V}$ , $I_{DS} = 10\text{ A}$		3.3		S
		$V_{DS} = 20\text{ V}$ , $I_{DS} = 10\text{ A}$ , $T_J = 175\text{ }^\circ\text{C}$		3.4		S
Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V}$		513		pF
Output Capacitance	$C_{OSS}$	$V_{DS} = 1000\text{ V}$		35		
Reverse Transfer Capacitance	$C_{RSS}$	$V_{AC} = 25\text{ mV}$		2		
$C_{OSS}$ Stored Energy	$E_{OSS}$	$f = 1\text{ MHz}$		20		
Internal Gate Resistance	$R_{G(int)}$	$f = 1\text{ MHz}$ , $AC = 25\text{ mV}$		6		$\Omega$
Gate to Source Charge	$Q_{gs}$	$V_{DS} = 800\text{ V}$ , $V_{GS} = -5 / 20\text{ V}$ $I_D = 10\text{ A}$		7		nC
Gate to Drain Charge	$Q_{gd}$			8		
Total Gate Charge	$Q_g$		Per IEC60747-8-4 pg 21		26	

\* Pulse width < 200  $\mu\text{s}$ .

## Reverse Diode Characteristics ( $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified)

Characteristics	Symbol	Conditions	Typ.	Max.	Units
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -5\text{ V}, I_{SD} = 5\text{ A}$	3.7		V
	$V_{SD}$	$V_{GS} = -5\text{ V}, I_{SD} = 5\text{ A}, T_J = 175^\circ\text{C}$	2.5		V
Reverse Recovery Time	$t_{rr}$	$V_{GS} = -5\text{ V}, I_{SD} = 10\text{ A}, T_J = 25\text{ }^\circ\text{C}$	6		ns
Reverse Recovery Charge	$Q_{rr}$	$V_R = 800\text{ V}$	40		nC
Peak Reverse Recovery Current	$I_{rm}$	$dif / dt = 2533\text{ A} / \mu\text{s}$	11		A

## Typical Performance

All the graphs are based on a die placed in a TO-247-4 package.

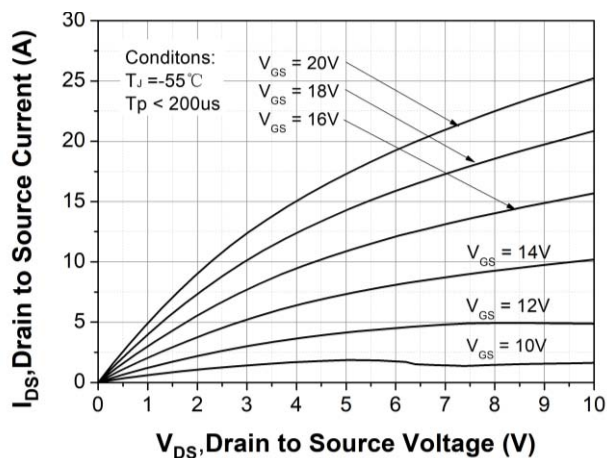


Figure 1. Output Characteristics  $T_J = -55\text{ }^\circ\text{C}$

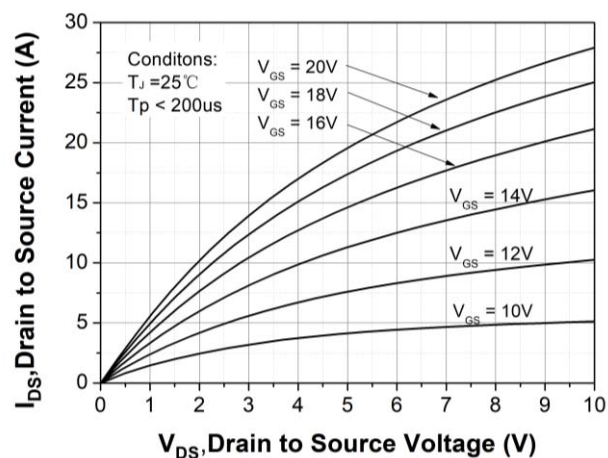


Figure 2. Output Characteristics  $T_J = 25\text{ }^\circ\text{C}$

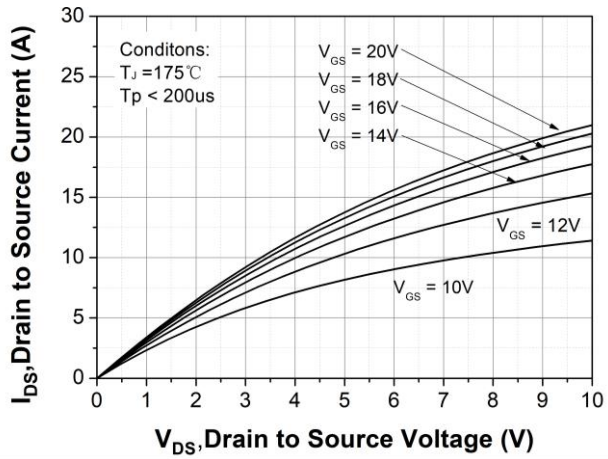


Figure 3. Output Characteristics  $T_J = 175^\circ\text{C}$

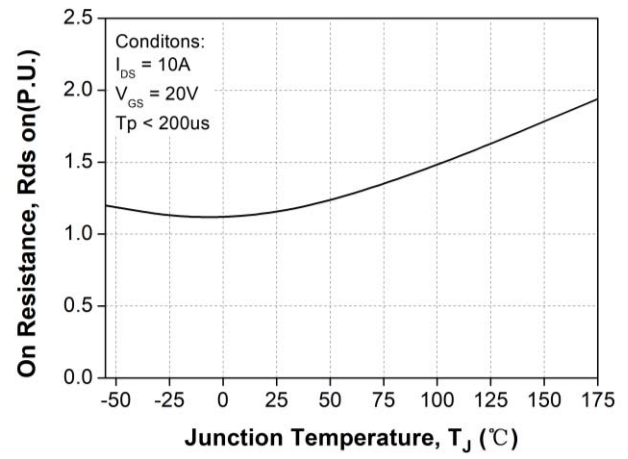


Figure 4. Normalized On-Resistance vs. Temperature

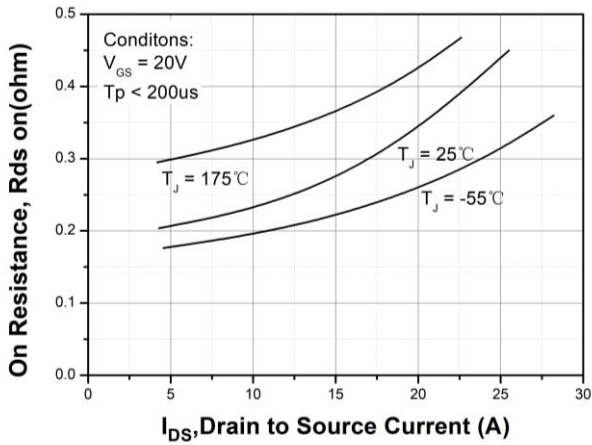


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

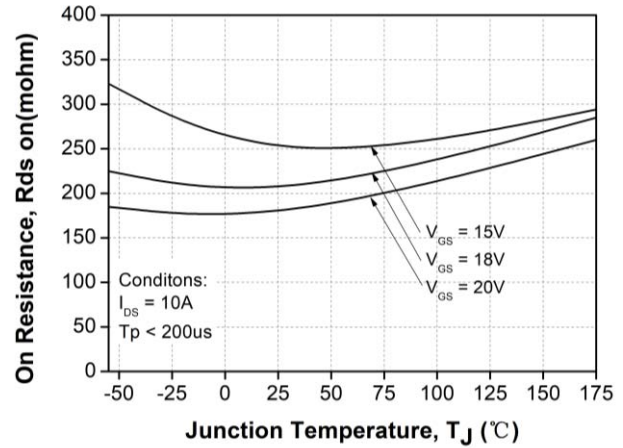


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

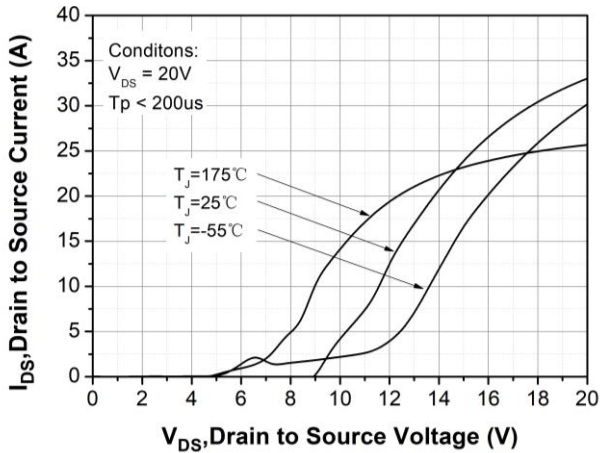


Figure 7. Transfer Characteristic for Various Junction Temperatures

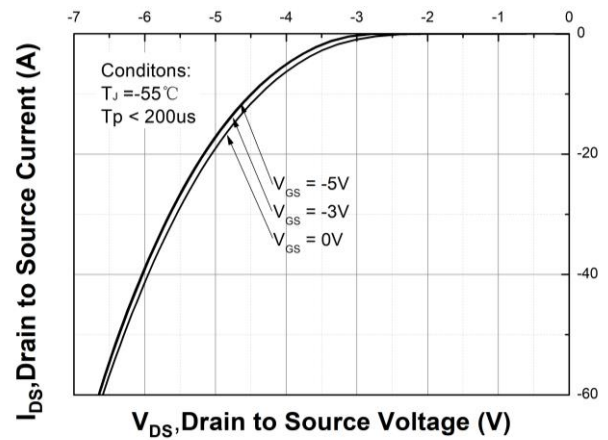


Figure 8. Body Diode Characteristic at  $T_J = -55^\circ\text{C}$

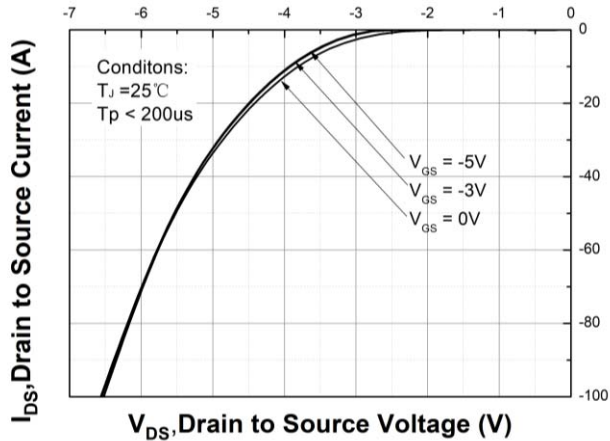


Figure 9. Body Diode Characteristic at  $T_J = 25^\circ\text{C}$

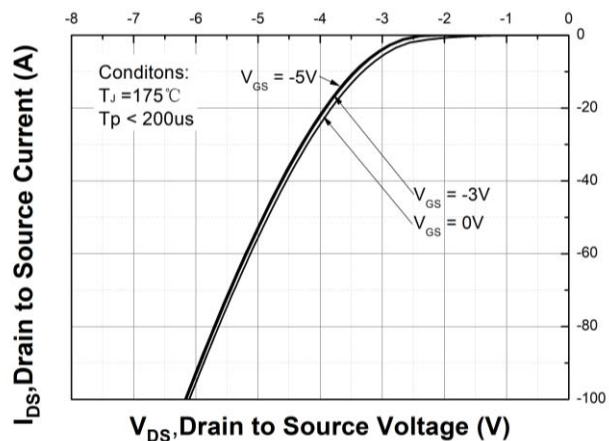


Figure 10. Body Diode Characteristic at  $T_J = 175^\circ\text{C}$

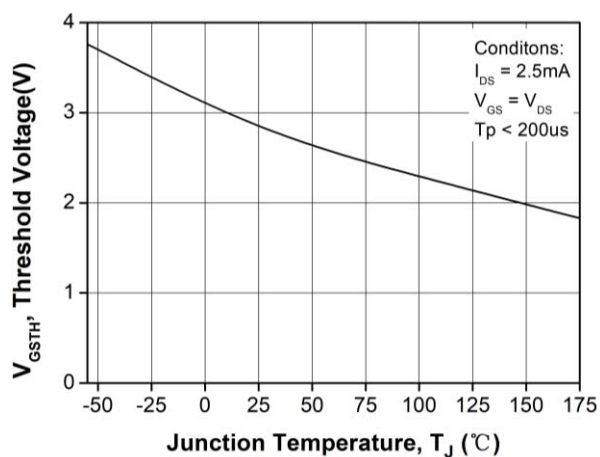


Figure 11. Threshold Voltage vs. Temperature

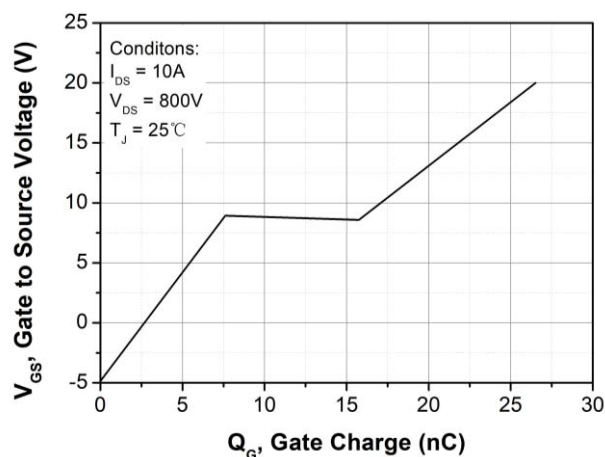


Figure 12. Gate Charge Characteristic

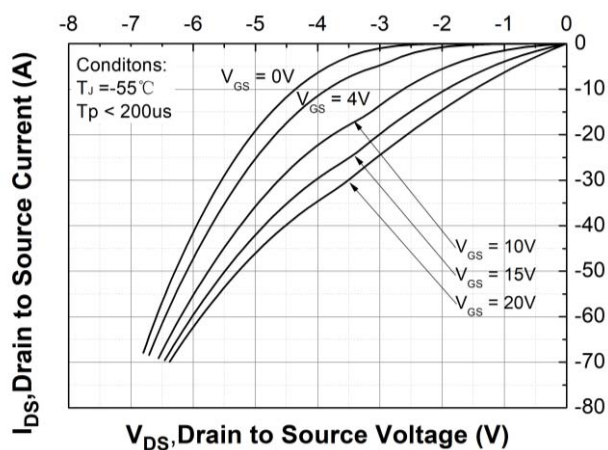


Figure 13. 3rd Quadrant Characteristic at  $T_J = -55^\circ\text{C}$

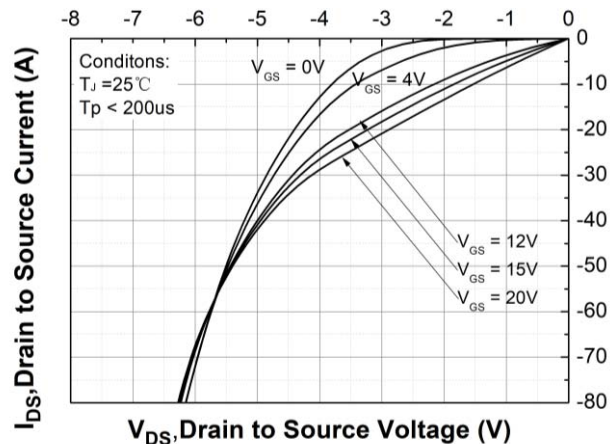


Figure 14. 3rd Quadrant Characteristic at  $T_J = 25^\circ\text{C}$

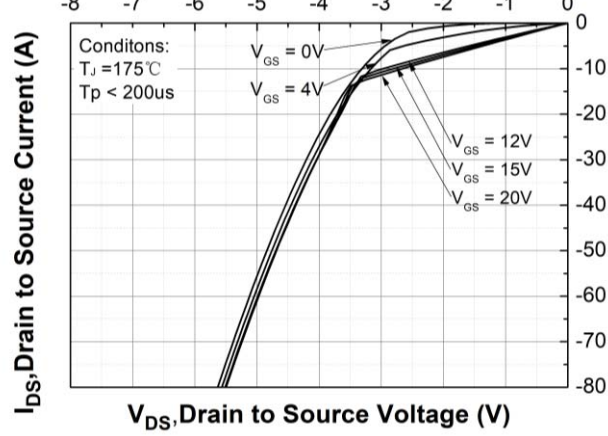


Figure 15. 3rd Quadrant Characteristic at  $T_J = 175\text{ }^\circ\text{C}$

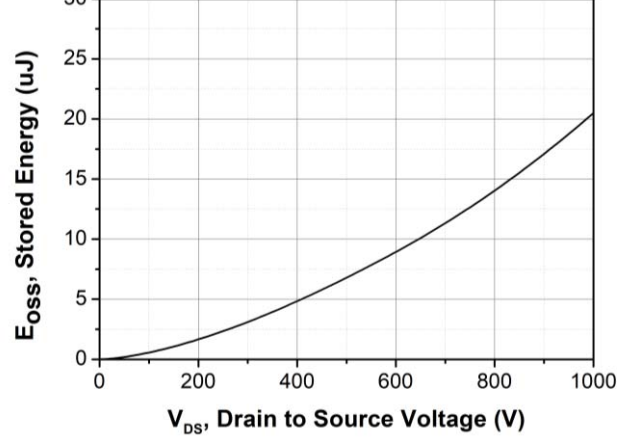


Figure 16. Output Capacitor Stored Energy

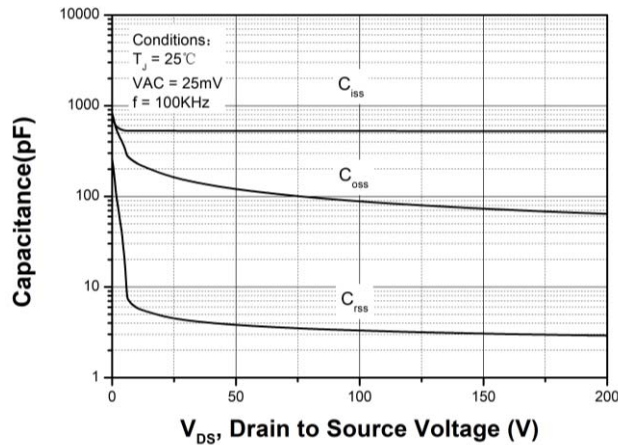


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200 V)

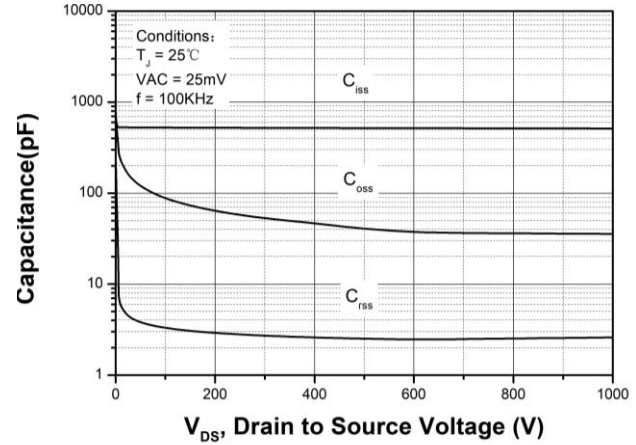


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000 V)

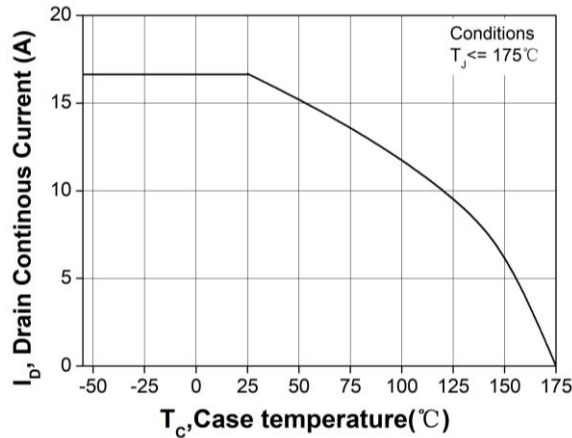


Figure 19. Continuous Drain Current Derating vs. Case Temperature

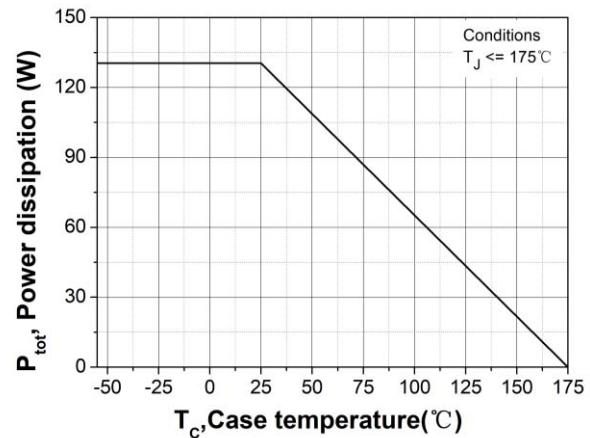


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

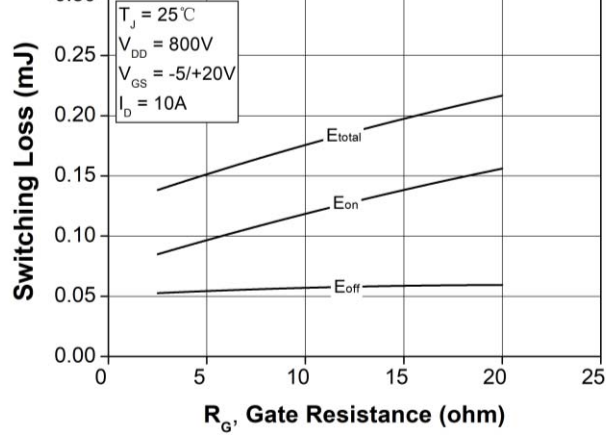


Figure 21. Transient Thermal Impedance (Junction - Case)

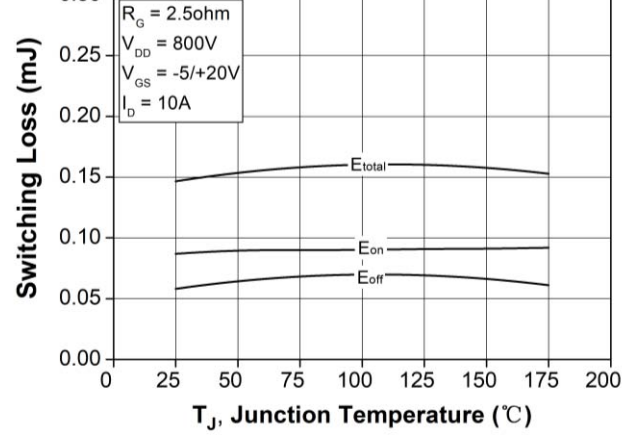


Figure 22. Safe Operating Area

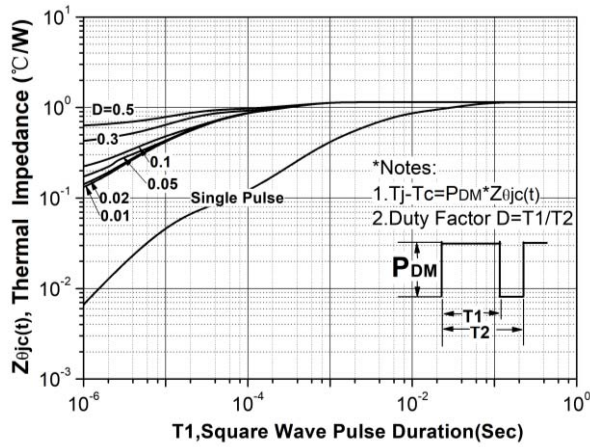


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 600V$ )

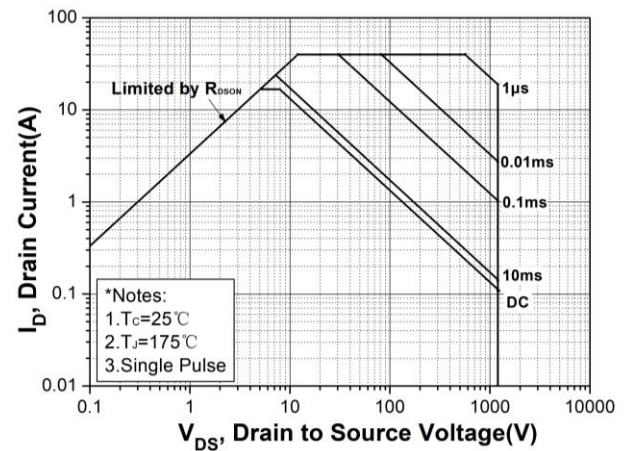


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 800V$ )

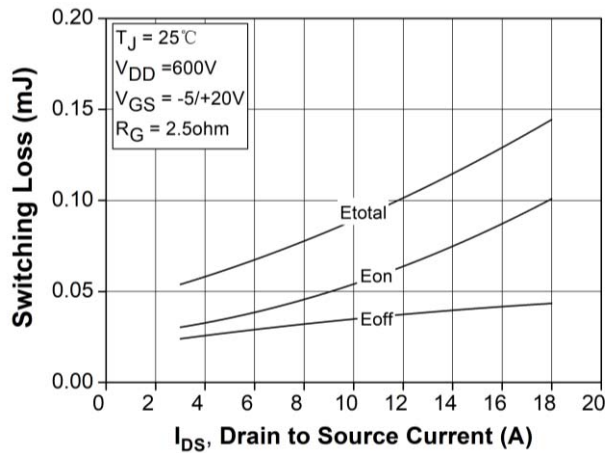


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

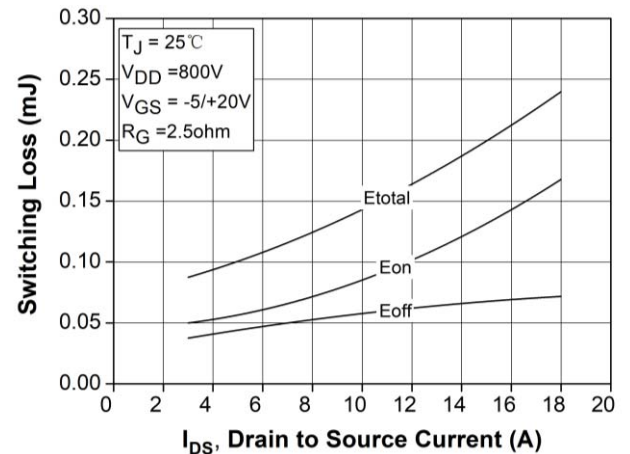


Figure 26. Clamped Inductive Switching Energy vs. Temperature

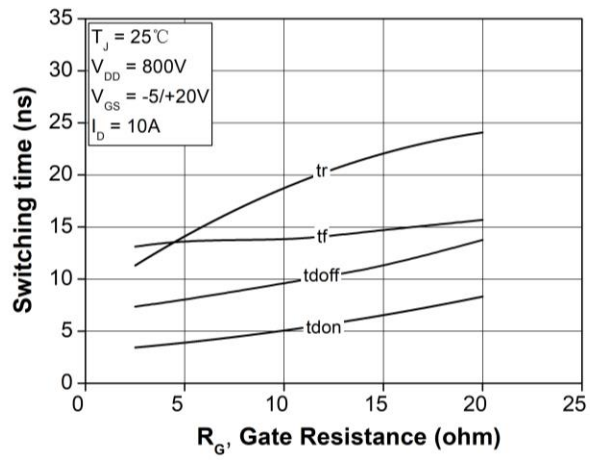


Figure 27. Switching Times vs.  $R_{G(\text{ext})}$

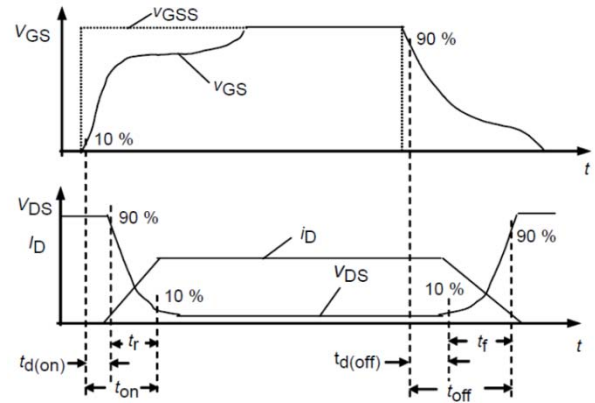
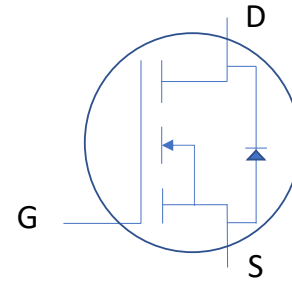
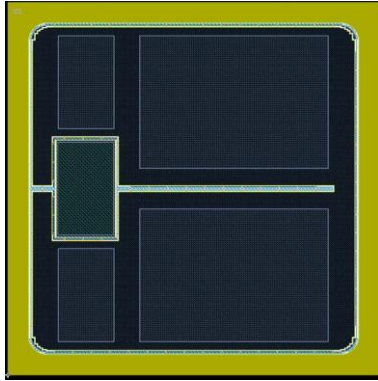


Figure 28. Switching Times Definition



# Mechanical Dimensions



Parameter	Typical Value	Unit
Die Dimensions (L x W)	Please contact your sales representative to get the detailed information about die layout and dimensions.	mm
Exposed Source Pad Metal Dimensions (L x W) Each		mm
Sense Pad Metal Dimensions (L x W)		mm
Gate Pad Dimensions (L x W)		mm
Top Side Source Metallization (Al)		$\mu\text{m}$
Top Side Gate Metallization (Al)		$\mu\text{m}$
Bottom Drain Metallization (Ni / Ag)		$\mu\text{m}$